## **AMENDMENTS TO THE CLAIMS:**

Claims 1, 2, 5, 9 and 10 have been amended, and claim 14 has been canceled as follows. This listing of claims will replace all prior versions, and listings, of claims in the application:

## **Listing of Claims:**

Claim 1 (Currently Amended): A matching box connected to a plasma generator for changing at least one of a phase of current and a phase of voltage of RF power inputted from an RF source and outputting phase-changed RF power to said plasma generator,

said matching box comprising a variable inductance element,

wherein said variable inductance element includes:

a main winding for determining impedance of said variable inductance element; and a control winding magnetically coupled to said main winding,

wherein an impedance of said main winding is controlled based on a magnitude of direct current flowing through said control winding, which is in turn based on plasma generation in said plasma generator when the disappearance of plasma is detected, the voltage outputted from said matching box is increased by changing said current flowing through said control winding.

Claim 2 (Currently Amended): A matching box having a high voltage side output terminal

connected to a plasma generator, an input terminal connected to an RF source, said matching box

for changing at least one of a phase of current and a phase of voltage of RF power inputted into said

input terminal and outputting phase-changed RF power to said high voltage side output terminal, said

matching box comprising a first variable inductance element, wherein said first variable inductance

element comprises:

a first main winding connected [[to]] in series between said input terminal and said high

voltage side output terminal; and

a first control winding magnetically coupled to said first main winding,

wherein an impedance of said first main winding is controlled based on a magnitude of direct

current flowing through said first control winding, which is in turn based on plasma generation in

said plasma generation.

Claim 3 (Previously Presented): The matching box according to claim 2, further comprising:

a first control power source,

wherein said first control winding is supplied with a current from said first control power

source.

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Claim 4 (Original): The matching box according to claim 3, wherein said first control power source is connected to a first control circuit, and a signal inputted from said first control circuit changes the magnitude of current outputted to said first control winding.

Claim 5 (Currently Amended): A matching box comprising:

a high voltage side output terminal connected to a plasma generator;

an input terminal connected to an RF source;

a ground side output terminal connected to ground voltage, said matching box changing at least one of a phase of current and a phase of voltage of RF power inputted into said input terminal and outputting phase-changed RF power from said high voltage side output terminal; and

a variable inductance element, the inductance of which is increased upon detection of the disappearance of plasma, wherein said variable inductance element comprises:

a main winding connected to said input terminal and said ground side output terminal; and a control winding magnetically coupled to said main winding,

wherein said main winding is controlled based on a magnitude of direct current flowing through said control winding, which is in turn based on plasma generation in said plasma generation.

Claim 6 (Previously Presented): The matching box according to claim 5, wherein said matching box has a control power source, and current from said control power source flows through said control winding.

Claim 7 (Previously Presented): The matching box according to claim 6, wherein said control power source is connected to a control circuit, and a signal inputted from said control circuit changes the magnitude of current outputted to said control winding.

Claim 8 (Previously Presented): A matching box according to claim 2, further comprising: a high voltage side output terminal connected to a plasma generator; an input terminal connected to an RF source;

a ground side output terminal connected to ground voltage, said matching box changing a phase of current and/or a phase of voltage of RF power inputted into said input terminal and outputting phase-changed RF power from said high voltage side output terminal; and

a second variable inductance element, wherein said second variable inductance element comprises:

a second main winding connected to said input terminal and said ground side output terminal; and

a second control winding magnetically coupled to said second main winding,

wherein said second main winding is controlled based on a magnitude of direct current flowing through said second control winding.

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Claim 9 (Currently Amended): A vacuum apparatus comprising:

a vacuum chamber;

an RF source;

a matching box having a variable inductance element for electrically controlling impedance;

and

a plasma generator, connected to said RF source via said matching box, for generating plasma

by RF voltage outputted from said RF source,

wherein said variable inductance element is connected between said RF source and said

plasma generator, wherein inductance of said variable inductance element is controlled based on

plasma generation in said plasma generator a ground side output terminal, the inductance of said

variable inductance element being increased upon detection of the disappearance of plasma, and

wherein a target object disposed in said vacuum chamber is subjected to vacuum processing.

Claim 10 (Currently Amended): The vacuum apparatus according to claim 9, wherein said

variable inductance element further comprises:

a main winding for determining the impedance of said variable inductance element; and

a control winding magnetically coupled to said main winding,

wherein a magnitude of direct current flowing through said control winding [[controll]]

control the impedance of said main winding.

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Claim 11 (Original): The vacuum apparatus according to claim 9, wherein said plasma

generator comprises:

an ionization chamber;

a coil wound around said ionization chamber;

a first electrode disposed in an opening of said ionization chamber; and

a second electrode disposed farther from said ionization chamber than said first electrode,

wherein said plasma generator is an ion gun, and gas supplied to said ionization chamber

forms plasma in an alternating current field formed by alternating current flowing through said coil,

and positive ions extracted from said plasma by said first and second electrodes are released into said

vacuum chamber.

Claim 12 (Original): The vacuum apparatus according to claim 10, further comprising an

electron generator for emitting electrons,

wherein when plasma is regenerated due to disappearance of said plasma, a voltage higher

than that of said vacuum chamber is applied to said second electrode in order to attract said electrons

emitted from said electron generator to said ionization chamber.

Claim 13 (Original): A method of vacuum processing comprising the steps of:

ionizing gas supplied to an ionization chamber by applying an alternating current field to said

gas to generate plasma;

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applying a positive voltage to a first electrode disposed in the vicinity of an opening of said

ionization chamber;

applying negative voltage to a second electrode disposed farther from said ionization

chamber than said first electrode;

releasing positive ions into a vacuum chamber, said positive ions being extracted from said

plasma by an electric field formed by said first and second electrodes,

releasing electrons from an electron generator into said vacuum chamber in order to

neutralize a flow of said positive ions by applying said electrons; and

irradiating said neutralized positive ions to a target object disposed inside said vacuum

chamber,

wherein when plasma is regenerated due to disappearance of said plasma, said electrons

emitted from said electron generator are attracted into said ionization chamber by applying a voltage

higher than that of said vacuum chamber to said second electrode.

Claim 14 (Canceled).

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